Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/624,653	PERAHIA ET AL.
Examiner	Art Unit

2616

Afsar M. Qureshi

SEARCHED					
Class	Subclass	Date	Examiner		
370	329,341- 346,349 437,468, 471	6/6/2007	AQ		
375	219,270,				
	301,347				
455	101				
	272		,		
	562.1				
		-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST, WEST, PgPub, EPO, IEEE	6/6/2007	AQ
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